Prüfbericht-Nr.: *Test report no.:*	CN25Q1WB 001	**Auftrags-Nr.:** *Order no.:*	48272750	Seite 1 von 32 *Page 1 of 32*
Kunden-Referenz-Nr.: *Client reference no.:*	N/A	**Auftragsdatum:** *Order date:*	2025-02-11	
Auftraggeber: *Client:*	Microchip Technology Inc. 2355 West Chandler Blvd. Chandler, Arizona 85224-6199, United States			
Prüfgegenstand: *Test item:*	Wireless MCU Module with Bluetooth® Low Energy 6.0 qualified, IEEE® 802.15.4			
Bezeichnung / Typ-Nr.: *Identification / Type no.:*	PIC32WM-BZ6204UC, PIC32WM-BZ6204UE			
Auftrags-Inhalt: *Order content:*	FCC Part 15C Test report (IEEE® 802.15.4)			
Prüfgrundlage: *Test specification:*	FCC 47CFR Part 15: Subpart C Section 15.247			
Wareneingangsdatum: *Date of sample receipt:*	2024-09-30			
Prüfmuster-Nr.: *Test sample no:*	A003830107-001, 005, 007, 008, 009 A003830107-013, 015, 017, 018, 021, 023			
Prüfzeitraum: *Testing period:*	2025-03-03 - 2025-04-24			
Ort der Prüfung: *Place of testing:*	EMC/RF Taipei Testing Site			
Prüflaboratorium: *Testing laboratory:*	Taipei Testing Laboratories			
Prüfergebnis*: *Test result*:*	Pass			
zusammengestellt von: *compiled by:*	Ryan Chen Senior Project Manager	**genehmigt von:** authorized by:	Brenda Chen Senior Project Manager	
Datum: *Date:* 2025-05-08		**Ausstellungsdatum:** *Issue date:* 2025-05-08		
Stellung / *Position:*		**Stellung** / *Position:*		
Sonstiges / *Other:*				
Zustand des Prüfgegenstandes bei Anlieferung: *Condition of the test item at delivery:*	Prüfmuster vollständig und unbeschädigt *Test item complete and undamaged*			

* Legende:	1 = sehr gut	2 = gut	3 = befriedigend	4 = ausreichend	5 = mangelhaft
	P(ass) = entspricht o.g. Prüfgrundlage(n)		F(ail) = entspricht nicht o.g. Prüfgrundlage(n)	N/A = nicht anwendbar	N/T = nicht getestet
** Legend:*	*1 = very good*	*2 = good*	*3 = satisfactory*	*4 = sufficient*	*5 = poor*
	P(ass) = passed a.m. test specification(s)		*F(ail) = failed a.m. test specification(s)*	*N/A = not applicable*	*N/T = not tested*

Dieser Prüfbericht bezieht sich nur auf das o.g. Prüfmuster und darf ohne Genehmigung der Prüfstelle nicht auszugsweise vervielfältigt werden. Dieser Bericht berechtigt nicht zur Verwendung eines Prüfzeichens.
This test report only relates to the a. m. test sample. Without permission of the test center this test report is not permitted to be duplicated in extracts. This test report does not entitle to carry any test mark.

Anmerkungen
Remarks

1	Alle eingesetzten Prüfmittel waren zum angegebenen Prüfzeitraum gemäß eines festgelegten Kalibrierungsprogramms unseres Prüfhauses kalibriert. Sie entsprechen den in den Prüfprogrammen hinterlegten Anforderungen. Die Rückverfolgbarkeit der eingesetzten Prüfmittel ist durch die Einhaltung der Regelungen unseres Managementsystems gegeben. Detaillierte Informationen bezüglich Prüfkonditionen, Prüfequipment und Messunsicherheiten sind im Prüflabor vorhanden und können auf Wunsch bereitgestellt werden. *The equipment used during the specified testing period was calibrated according to our test laboratory calibration program. The equipment fulfils the requirements included in the relevant standards. The traceability of the test equipment used is ensured by compliance with the regulations of our management system.* *Detailed information regarding test conditions, equipment and measurement uncertainty is available in the test laboratory and could be provided on request.*
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3	Prüfklausel mit der Note * wurden an qualifizierte Unterauftragnehmer vergeben und sind unter der jeweiligen Prüfklausel des Berichts beschrieben. Abweichungen von Prüfspezifikation(en) oder Kundenanforderungen sind in der jeweiligen Prüfklausel im Bericht aufgeführt. *Test clauses with remark of * are subcontracted to qualified subcontractors and descripted under the respective test clause in the report.* *Deviations of testing specification(s) or customer requirements are listed in specific test clause in the report.*
4	Die Entscheidungsregel für Konformitätserklärungen basierend auf numerischen Messergebnisen in diesem Prüfbericht basiert auf der "Null-Grenzwert-Regel" und der "Einfachen Akzeptanz" gemäß ILAC G8:2019 und IEC Guide 115:2023, es sei denn, in der auf Seite 1 dieses Berichts genannten angewandten Norm ist etwas anderes festgelegt oder vom Kunden gewünscht. Dies bedeutet, dass die Messunsicherheit nicht berücksichtigt wird und daher auch nicht im Prüfbericht angegeben wird. Zu weiteren Informationen bezueglich des Risikos durch diese Entscheidungsregel siehe ILAC G8:2019. *The decision rule for statements of conformity, based on numerical measurement results, in this test report is based on the "Zero Guard Band Rule" and "Simple Acceptance" in accordance with ILAC G8:2019 and IEC Guide 115:2023, unless otherwise specified in the applied standard mentioned on Page 1 of this report or requested by the customer. This means that measurement uncertainty is not taken in account and hence also not declared in the test report. For additional information to the resulting risk based of this decision rule please refer to ILAC G8:2019.*

TEST SUMMARY

Report Section	FCC Clause	Test Item	Result
5.1.1	15.247(b) & 15.203	Antenna Requirement	Pass
5.1.2	15.247(b)(3)	Peak Output Power	Pass
5.1.3	15.247(a)(2)	6 dB Bandwidth	Pass
5.1.3	2.1049	99% Occupied Bandwidth	Pass
5.1.4	15.247(e)	Power Spectral Density	Pass
5.1.5	15.247(d)	Conducted Spurious Emissions and Band Edges	Pass
5.1.6	15.247(d) & 15.205 & 15.209	Radiated Spurious Emissions and Band Edges	Pass
5.2.1	15.207	Mains Conducted Emission	Pass

Note: Determining compliance based on the results of the compliance measurement, not taking into account measurement instrumentation uncertainty.

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APPENDIX A - TEST RESULT OF CONDUCTED

APPENDIX B - TEST RESULTS OF RADIATED SPURIOUS EMISSIONS & MAINS CONDUCTED EMISSION FOR DIPOLE ANTENNA

APPENDIX C - TEST RESULTS OF RADIATED SPURIOUS EMISSIONS & MAINS CONDUCTED EMISSION FOR FPCB ANTENNA

APPENDIX D - TEST RESULTS OF RADIATED SPURIOUS EMISSIONS FOR PCB ANTENNA

APPENDIX SP - PHOTOGRAPHS OF TEST SETUP

APPENDIX EP - PHOTOGRAPHS OF EUT

HISTORY OF THIS TEST REPORT

Revision	Description	Date Issued
R01	Original Release	2025-05-08

1. General Remarks

1.1 Complementary Materials

All attachments are integral parts of this test report. This applies especially to the following appendix:
Appendix A - Test Result of Conducted
Appendix B - Test Results of Radiated Spurious Emissions & Mains Conducted Emission for Dipole Antenna
Appendix C - Test Results of Radiated Spurious Emissions & Mains Conducted Emission for FPCB Antenna
Appendix D - Test Results of Radiated Spurious Emissions for PCB Antenna
Appendix SP - Photographs of Test Setup
Appendix EP - Photographs of EUT

Applied Standard and Test Levels

Radio
FCC 47CFR Part 15: Subpart C Section 15.247 FCC 47CFR Part 2: Subpart J Section 2.1049 ANSI C63.10:2013 KDB 558074 D01 15.247 Meas Guidance v05r02

1.2 Decision Rule of Conformity

The decision rule of conformity of this test report is following the requirements of the requested standard in the quotation, and agreed among testing laboratory and manufacturer (applicant) to exclude the consideration of Measurement Uncertainty, unless it is required by the specific standard.

2. Test Sites

2.1 Test Laboratory

Taipei Testing Laboratories

11F. No.758, Sec. 4, Bade Rd., Songshan Dist.
Taipei City 105
Taiwan (R.O.C.)

2.2 Test Facility

Taipei Testing Laboratories

No.458-18, Sec. 2, Fenliao Rd., Linkou Dist.,
New Taipei City 244
Taiwan (R.O.C.)
FCC Registration No.: 180491
ISED Registration No.: 25563

2.3 Traceability

All measurement equipment calibrations are traceable to NML(Taiwan)/NIST(USA) or where calibration is performed outside Taiwan, to equivalent nationally recognized standards organizations.

2.4 Calibration

Equipment requiring calibration is calibrated periodically in a suitably accredited Calibration Lab. Additionally all equipment is verified for proper performance on a regular basics using in house standards or comparisons.

2.5 Measurement Uncertainty

All measurement uncertainty values are shown with a coverage factor of k=2 to indicate a 95% level of confidence.

Emission Measurement Uncertainty

Parameter	Uncertainty
Radiated Emission (9 kHz ~ 30 MHz)	± 1.15 dB
Radiated Emission (30 MHz ~ 200 MHz)	± 1.32 dB
Radiated Emission (200 MHz ~ 1 GHz)	± 1.31 dB
Radiated Emission (1 GHz ~ 18 GHz)	± 1.53 dB
Radiated Emission (18 GHz ~ 40 GHz)	± 2.50 dB
Mains Conducted Emission	± 1.65 dB

3. General Product Information

3.1 Product Function and Intended Use

The EUT is a Wireless MCU Module with Bluetooth® Low Energy 6.0 qualified, IEEE® 802.15.4. It contains an IEEE® 802.15.4 compatible module enabling the user to communicate data through a Wireless interface.
For details refer to the User Guide, Data Sheet and Circuit Diagram.

3.2 System Details and Ratings

Basic Information of EUT

Item	EUT information
Kind of Equipment/Test Item	Wireless MCU Module with Bluetooth® Low Energy 6.0 qualified, IEEE® 802.15.4
Type Identification	PIC32WM-BZ6204UC, PIC32WM-BZ6204UE
FCC ID	2ADHKBZ6204

Technical Specification of EUT

Item	EUT information
Operating Frequency	2405 MHz ~ 2480 MHz
Channel Spacing	2 MHz
Channel Number	16
Data Rate	1Mbps, 2Mbps, 250kbps, 500kbps
Operation Voltage	3.3 Vdc
Modulation	OQPSK
Maximum Output Power (mW)	16.63
Antenna Information	Refer to 5.1.1
Accessory Device	Refer to 4.4

Note:
1. All models are listed as below.

Model Type	Type Identification	Difference	
Main	PIC32WM-BZ6204UC	U.FL variant WITH ECC chip	All models are electrically identical, different model names are for marketing purpose. Both models are using external antennas (U.FL) and have the same hardware layout design, the difference is having the ECC chip or not. UC is U.FL variant WITH ECC chip ; UE is U.FL WITHOUT ECC chip.
Series	PIC32WM-BZ6204UE	UE is U.FL WITHOUT ECC chip	

3.3 Noise Generating and Noise Suppressing Parts

Refer to the Circuit Diagram.

3.4 Submitted Documents

- Circuit Diagram
- Instruction Manual
- Rating Label
- Technical Description

4. Test Set-up and Operation Modes

4.1 Principle of Configuration Selection

The test modes were adapted accordingly in reference to the instructions for use.
During testing, Channel and Power Controlling Software provided by the customer was used to control the operating channel as well as the output power level. The RF output power selection is for the setting of RF output expected by the customer and is going to be fixed on the firmware of the final end product.

Table for Parameters of Test Software Setting

Mode	Frequency (MHz)	Power Setting
250kbps	2405	Level 0
	2440	Level 0
	2480	Level 0
500kbps	2405	Level 0
	2440	Level 0
	2480	Level 0
1Mbps	2405	Level 0
	2440	Level 0
	2480	Level 0
2Mbps	2405	Level 0
	2440	Level 0
	2480	Level 0

4.2 Carrier Frequency and Channel

Channel	Freq. (MHz)	Channel	Freq. (MHz)
11	2405	19	2445
12	2410	20	2450
13	2415	21	2455
14	2420	22	2460
15	2425	23	2465
16	2430	24	2470
17	2435	25	2475
18	2440	26	2480

4.3 Test Operation and Test Software

Setup for testing: Test samples are provided with a USB interface which makes it possible to control them through a test software installed on a notebook computer.
This software was running on the laptop computer connected to the EUT. It was used to enable the operation modes listed as below.

Test Software	MCHPRT3_Setup_v1.0.2.8270

The samples were used as follows:
A003830107-001, 005, 007, 008, 009
A003830107-013, 015, 017, 018, 021, 023
Full test was applied on all test modes, but only worst case was shown.

EUT Configure Mode	Applicable To				Description
	Antenna Port Conducted Measurement	Radiated Spurious Emissions above 1 GHz	Radiated Spurious Emissions below 1 GHz	Mains Conducted Emission	
-	√	√	√	√	-

Note:
1. The EUT had been pre-tested on the positioned of each 3 axis. The worst case was found when position on X-plane for ANT 6, 14, 15; Y-plane for ANT 13; Z-plane for ANT 11, 12.
2. "-" means no effect.
3. For the 2nd source, we only evaluate the output power and the worst case of RSE tests
4. ECC (Trust and Go IC)

Antenna Port Conducted Measurement

☒ Pre-Scan full test was applied on all test modes, but only worst case was shown.
☒ Following channel(s) was (were) selected for the final test as listed below.

EUT Configure Mode	Available Frequency (MHz)	Tested Frequency (MHz)	Date Rate (Mbps)
-	2405 to 2480	2405, 2440, 2480	0.25
	2405 to 2480	2405, 2440, 2480	0.5
	2405 to 2480	2405, 2440, 2480	1
	2405 to 2480	2405, 2440, 2480	2

Radiated Spurious Emissions (Above 1 GHz)

☒ Pre-Scan full test was applied on all test modes, but only worst case was shown.
☒ Following channel(s) was (were) selected for the final test as listed below.

EUT Configure Mode	Available Frequency (MHz)	Tested Frequency (MHz)	Date Rate (Mbps)
-	2405 to 2480	2405, 2440, 2480	0.25
-	2405 to 2480	2405, 2440, 2480	2

Radiated Spurious Emissions (Below 1 GHz)

☒ Pre-Scan full test was applied on all test modes, but only worst case was shown.
☒ Following channel(s) was (were) selected for the final test as listed below.

EUT Configure Mode	Available Frequency (MHz)	Tested Frequency (MHz)	Date Rate (Mbps)
-	2405 to 2480	2405	0.25

Mains Conducted Emission

☒ Pre-Scan full test was applied on all test modes, but only worst case was shown.
☒ Following channel(s) was (were) selected for the final test as listed below.

EUT Configure Mode	Available Frequency (MHz)	Tested Frequency (MHz)	Date Rate (Mbps)
-	2405 to 2480	2405	0.25

Test Condition

Test Item	Ambient Temperature	Relative Humidity	Tested by
Conducted Measurement	20.2-23.4 °C	56-63.5 %	Nick Guan and Blake Wang
Radiated Spurious Emissions above 1 GHz	22.7-24.8 °C	52-55 %	Ivan Chiang
Radiated Spurious Emissions below 1 GHz	22.7-24.8 °C	52-55 %	Ivan Chiang
Mains Conducted Emission	23.7-24.5 °C	52-55 %	Ivan Chiang

4.4 Special Accessories and Auxiliary Equipment

The product has been tested together with the following additional accessories:

Accessory of EUT

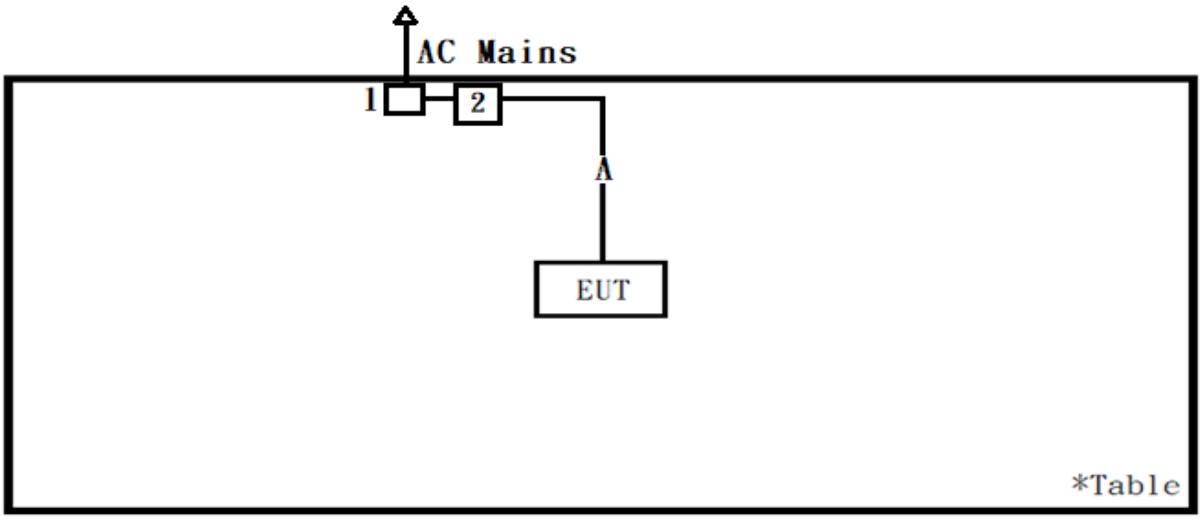
N/A

Support Unit

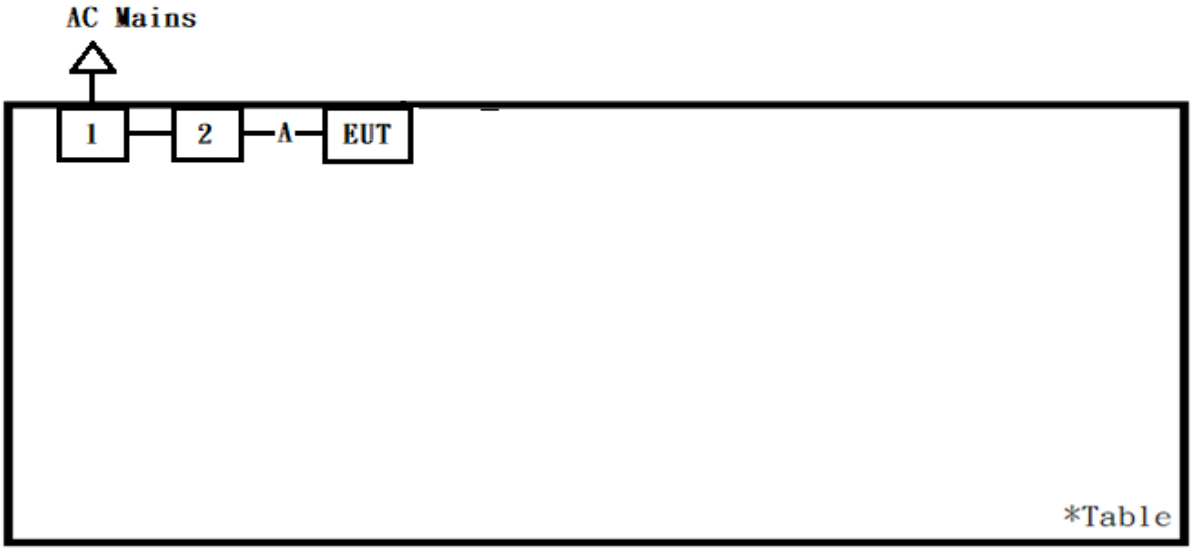
Support Unit								
No	Description	Brand	Model	S/N	Shielded	Ferrite Core (Qty)	Length (cm)	Remark
Radiated and Mains Conducted Tests								
A	USB Cable	Microchip	-	-	-	95	-	A003938566-013
1	Adapter	HP	TPN-DA17	-	-	-	180	-
2	Notebook	HP	15-da1046TX	CND9111RJB	-	-	-	-
Conducted Test								
-	Notebook	HP	TPN-Q222	5CD2206L9Y	-	-	-	-
-	USB Type-C to USB Type-A	TUV	TUV-06	1	-	-	-	-

4.5 Test Setup Diagram

<Radiated Spurious Emissions Mode>



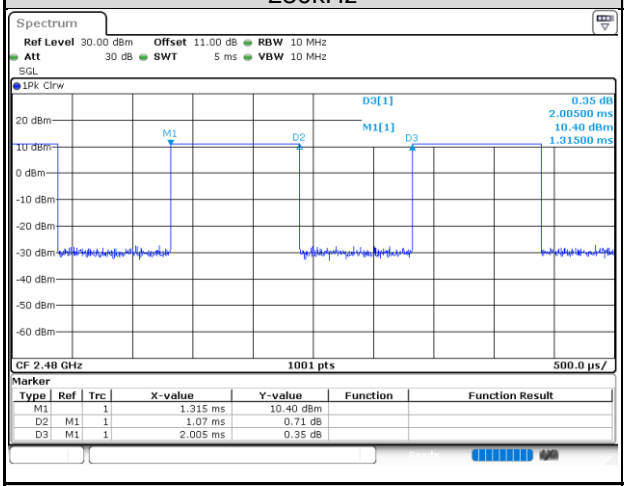
<Mains Conducted Emission mode>



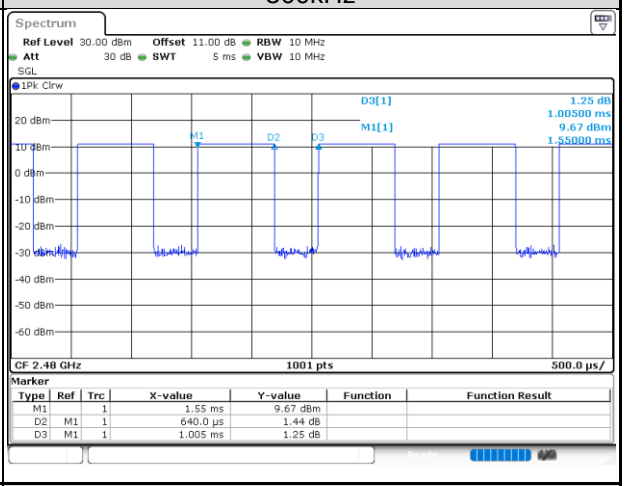
4.6 Duty Cycle of Test Signal

Mode	On + Off Time (ms)	On Time (ms)	Duty Cycle (%)	Duty Factor (dB)
250kHz	2.005	1.07	53.37	2.73
500kHz	1.005	0.64	63.68	1.96
1Mbps	1.005	0.42	41.79	3.79
2Mbps	1.000	0.31	31.00	5.09

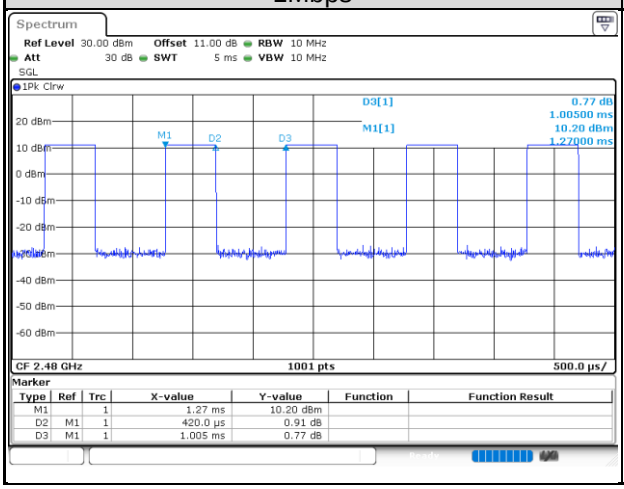
250kHz



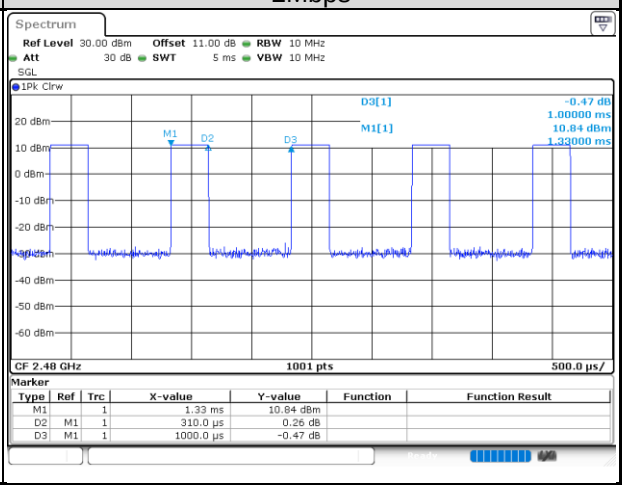
500kHz



1Mbps



2Mbps



5. Test Results

5.1 Transmitter Requirement & Test Suites

5.1.1 Antenna Requirement

Requirement Use of approved antennas only

According to the manufacturer declaration, the EUT has an antenna with a directional gain of 3.35 dBi. The antenna is a printed PCB trace with no possibility of replacement with a non-approved antenna by the end-user. Therefore, the EUT is considered to comply with this provision.
Refer to EUT photo for details.
*ANT no.: 6,11 are selected for the Main radiated test..
*ANT no.: 12, 13, 14, 15 are selected for the spot check of radiated test.

ANT No.	Brand Name	SN/Model #	Antenna Type	Gain (dBi)	Placement
1	Linx Technologies	ANT-2.4-LPW-125	Dipole	2.8	External
2	Aristotle	RFA-02-L2H1	Dipole	2	External
3	Aristotle	RFA-02-C2H1-D034	Dipole	2	External
4	Aristotle	RFA-02-D3	Dipole	2	External
5	Walsin	RFDPA870910IMAB308	Dipole	2.04	External
6	Pulse	W1049B030	Dipole	2.85	External
7	Walsin	RFDPA870920IMLB301	Dipole	1.84	External
8	Walsin	RFDPA870920IMAB302	Dipole	1.82	External
9	Walsin	RFDPA870920IMAB305	Dipole	1.82	External
10	Walsin	RFDPA870915IMAB306	Dipole	1.82	External
11	TAOGLAS	FXP840.07.0055B	FPCB	3.35	External
12	Quectel	YF0026AA	FPCB	2.1	External
13	TAOGLAS	FXP70.07.0053A	FPCB	1.1	External
14	Aristotle	RFA-02-P05-D034	PCB	2	External
15	Aristotle	RFA-02-P33-D034	PCB	2	External

5.1.2 Peak Output Power

Limit 1 watt (30 dBm)

Kind of Test Site Shielded room

Test Setup

Test Instruments

Kind of Equipment	Manufacturer	Type	S/N	Calibration Date	Calibration Due Date	Test Date	
						From	Until
Power Meter	Anritsu	ML2495A	1901008	2025/2/26	2026/2/25	2025/3/3	2025/4/18
Power Sensor	Anritsu	MA2411B	1725269	2025/2/26	2026/2/25	2025/3/3	2025/4/18

Test Procedures

A peak power sensor was used on the output port of the EUT. A power meter was used to read the response of the peak power sensor. Record the power level.

Average power sensor was used to perform output power measurement, trigger and gating function of wide band power meter is enabled to measure max output power of TX on burst. Duty factor is not added to measured value.

Test Result

Peak Output Power, Main Source

<250kbps>

Channel	Channel Frequency	Peak Output Power		Limit (dBm)
	(MHz)	(dBm)	(mW)	
Low Channel	2405	12.21	16.63	30
Middle Channel	2440	12.20	16.60	30
High Channel	2480	12.12	16.29	30

<500kbps>

Channel	Channel Frequency	Peak Output Power		Limit (dBm)
	(MHz)	(dBm)	(mW)	
Low Channel	2405	12.20	16.60	30
Middle Channel	2440	12.19	16.56	30
High Channel	2480	12.12	16.29	30

<1Mbps >

Channel	Channel Frequency	Peak Output Power		Limit (dBm)
	(MHz)	(dBm)	(mW)	
Low Channel	2405	12.19	16.56	30
Middle Channel	2440	12.17	16.48	30
High Channel	2480	12.10	16.22	30

<2Mbps >

Channel	Channel Frequency	Peak Output Power		Limit (dBm)
	(MHz)	(dBm)	(mW)	
Low Channel	2405	12.19	16.56	30
Middle Channel	2440	12.18	16.52	30
High Channel	2480	12.11	16.26	30

Peak Output Power, 2nd Source

<250kbps>

Channel	Channel Frequency	Peak Output Power		Limit (dBm)
	(MHz)	(dBm)	(mW)	
Low Channel	2405	11.82	15.21	30
Middle Channel	2440	11.85	15.31	30
High Channel	2480	11.83	15.24	30

<500kbps>

Channel	Channel Frequency	Peak Output Power		Limit (dBm)
	(MHz)	(dBm)	(mW)	
Low Channel	2405	11.82	15.21	30
Middle Channel	2440	11.84	15.28	30
High Channel	2480	11.82	15.21	30

<1Mbps >

Channel	Channel Frequency	Peak Output Power		Limit (dBm)
	(MHz)	(dBm)	(mW)	
Low Channel	2405	11.81	15.17	30
Middle Channel	2440	11.84	15.28	30
High Channel	2480	11.82	15.21	30

<2Mbps >

Channel	Channel Frequency	Peak Output Power		Limit (dBm)
	(MHz)	(dBm)	(mW)	
Low Channel	2405	11.82	15.21	30
Middle Channel	2440	11.85	15.31	30
High Channel	2480	11.82	15.21	30

Average Power, Main Source

<250kbps>

Channel	Channel Frequency	Peak Output Power		Limit (dBm)
	(MHz)	(dBm)	(mW)	
Low Channel	2405	12.18	16.52	30
Middle Channel	2440	12.17	16.48	30
High Channel	2480	12.09	16.18	30

<500kbps>

Channel	Channel Frequency	Peak Output Power		Limit (dBm)
	(MHz)	(dBm)	(mW)	
Low Channel	2405	12.17	16.48	30
Middle Channel	2440	12.16	16.44	30
High Channel	2480	12.09	16.18	30

<1Mbps >

Channel	Channel Frequency	Peak Output Power		Limit (dBm)
	(MHz)	(dBm)	(mW)	
Low Channel	2405	12.16	16.44	30
Middle Channel	2440	12.14	16.37	30
High Channel	2480	12.07	16.11	30

<2Mbps >

Channel	Channel Frequency	Peak Output Power		Limit (dBm)
	(MHz)	(dBm)	(mW)	
Low Channel	2405	12.16	16.44	30
Middle Channel	2440	12.15	16.41	30
High Channel	2480	12.08	16.14	30

Average Power, 2nd Source

<250kbps>

Channel	Channel Frequency	Peak Output Power		Limit (dBm)
	(MHz)	(dBm)	(mW)	
Low Channel	2405	11.79	15.10	30
Middle Channel	2440	11.82	15.21	30
High Channel	2480	11.79	15.10	30

<500kbps>

Channel	Channel Frequency	Peak Output Power		Limit (dBm)
	(MHz)	(dBm)	(mW)	
Low Channel	2405	11.79	15.10	30
Middle Channel	2440	11.80	15.14	30
High Channel	2480	11.79	15.10	30

<1Mbps >

Channel	Channel Frequency	Peak Output Power		Limit (dBm)
	(MHz)	(dBm)	(mW)	
Low Channel	2405	11.78	15.07	30
Middle Channel	2440	11.80	15.14	30
High Channel	2480	11.79	15.10	30

<2Mbps >

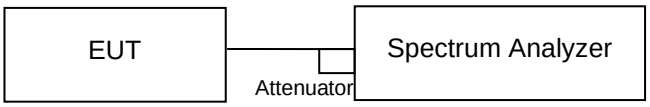
Channel	Channel Frequency	Peak Output Power		Limit (dBm)
	(MHz)	(dBm)	(mW)	
Low Channel	2405	11.79	15.10	30
Middle Channel	2440	11.81	15.17	30
High Channel	2480	11.79	15.10	30

5.1.3 6 dB Bandwidth and 99% Occupied Bandwidth

Limit The minimum 6 dB bandwidth shall be at least 500 kHz.

Kind of Test Site Shielded room

Test Setup



Test Instruments

Kind of Equipment	Manufacturer	Type	S/N	Calibration Date	Calibration Due Date	Test Date	
						From	Until
Spectrum Analyzer	R&S	FSV	101512	2025/02/26	2026/02/25	2025/3/3	2025/4/18

Test Procedure

a. Set resolution bandwidth (RBW) = 100 kHz
b. Set the video bandwidth (VBW) ≥ 3 x RBW, Detector = Peak.
c. Trace mode = max hold.
d. Sweep = auto couple.
e. Measure the maximum width of the emission that is constrained by the frequencies associated with the two amplitude points (upper and lower) that are attenuated by 6 dB relative to the maximum level measured in the fundamental emission.
f. For 99% occupied bandwidth measurement, the transmitter output was connected to the spectrum analyzer through an attenuator. The bandwidth of the fundamental frequency was measured by spectrum analyzer with resolution bandwidth in the range of 1% to 5% of the anticipated emission bandwidth, and a video bandwidth at least 3x the resolution bandwidth and set the detector to PEAK. The width of a frequency band such that, below the lower and above the upper frequency limits, the mean powers emitted are each equal to a specified percentage 0.5% of the total mean power of a given emission.

Test Results

Please refer to Appendix A.

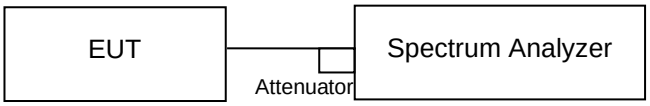
5.1.4 Power Spectral Density

Limit

The power spectral density shall not be greater than 8 dBm in any 3 kHz band.

Kind of Test Site Shielded room

Test Setup



Test Instruments

Kind of Equipment	Manufacturer	Type	S/N	Calibration Date	Calibration Due Date	Test Date	
						From	Until
Spectrum Analyzer	R&S	FSV	101512	2025/02/26	2026/02/25	2025/3/3	2025/4/18

Test Procedure

a. Set analyzer center frequency to DTS channel center frequency.
b. Set the span to 1.5 times the DTS bandwidth.
c. Set the RBW to: 3 kHz ≤ RBW ≤ 100 kHz.
d. Set the VBW ≥ 3 × RBW.
e. Detector = peak.
f. Sweep time = auto couple.
g. Trace mode = max hold.
h. Allow trace to fully stabilize.
i. Use the peak marker function to determine the maximum amplitude level within the RBW.

Test Results

Please refer to Appendix A.

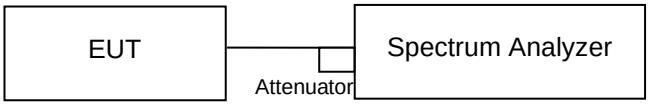
5.1.5 Conducted Spurious Emissions and Frequency Band Edges Measured in 100kHz Bandwidth

Limit

20dB (below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power.)

Kind of Test Site Shielded room

Test Setup



Test Instruments

Kind of Equipment	Manufacturer	Type	S/N	Calibration Date	Calibration Due Date	Test Date	
						From	Until
Spectrum Analyzer	R&S	FSV	101512	2025/02/26	2026/02/25	2025/3/3	2025/4/18

Test Procedure

Measurement procedure REF
1. Set the RBW = 100 kHz.
2. Set the VBW ≥ 300 kHz.
3. Detector = peak.
4. Sweep time = auto couple.
5. Trace mode = max hold.
6. Allow trace to fully stabilize.
7. Use the peak marker function to determine the maximum power level in any 100 kHz band segment within the fundamental EBW.

Measurement procedure OOBE
1. Set RBW = 100 kHz.
2. Set VBW ≥ 300 kHz.
3. Detector = peak.
4. Sweep = auto couple.
5. Trace Mode = max hold.
6. Allow trace to fully stabilize.
7. Use the peak marker function to determine the maximum amplitude level.

Test Results

Please refer to Appendix A.

5.1.6 Radiated Spurious Emissions and Band Edges

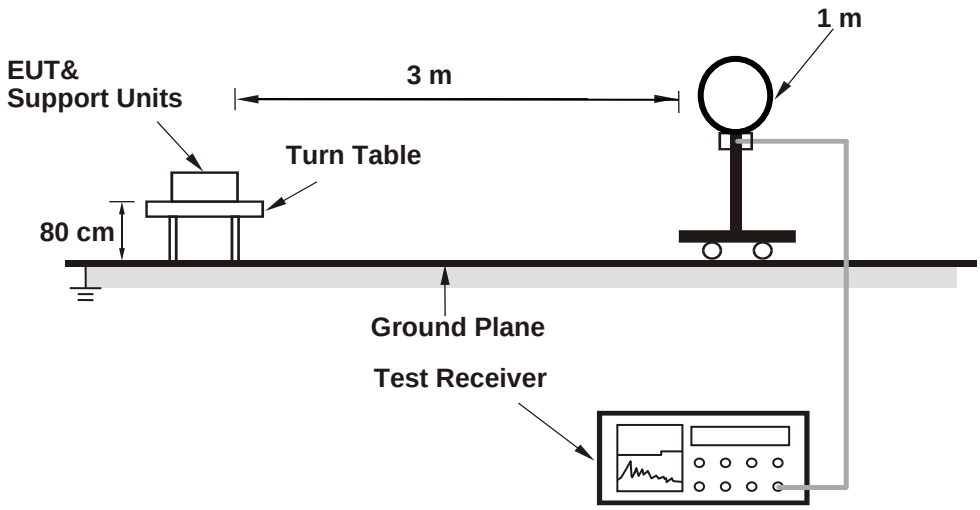
Limit

Radiated emissions which fall in the restricted bands, as defined in §15.205(a), must comply with the radiated emission limits specified in §15.209(a).
Emissions radiated outside the restricted and authorized frequency bands must either comply with the radiated emission limits specified for the restricted bands or in §15.247(d).

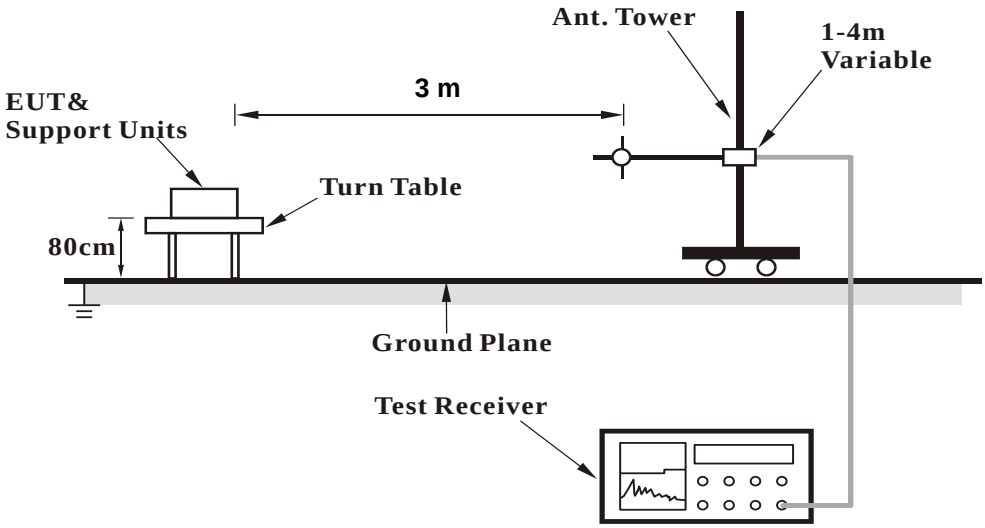
Kind of Test Site 3m Semi-Anechoic Chamber

Test Setup

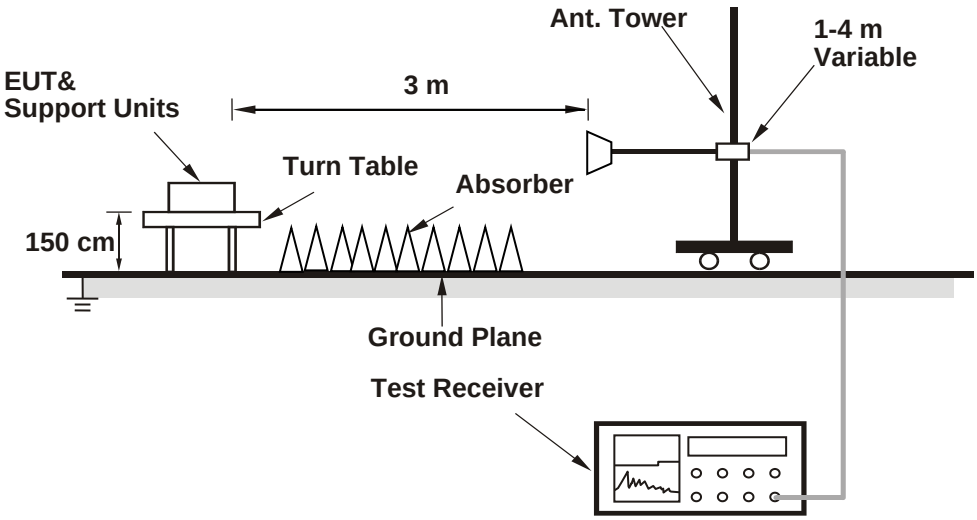
<Radiated Emissions below 30 MHz>



<Radiated Emissions 30 MHz to 1 GHz>



<Radiated Emissions above 1 GHz>



For the actual test configuration, please refer to the attached file (Test Setup Photo).

Test Instruments

Test Date: 2025/4/16 ~ 2025/4/24

Kind of Equipment	Manufacturer	Type	S/N	Calibration Date	Calibration Due Date
Above 1GHz					
Signal Analyzer	R&S	FSV40	101509	2024/4/30	2025/4/29
Horn Antenna	ETS-Lindgren	3117	00218929	2024/11/21	2025/11/20
Horn Antenna	SCHWARZBECK	BBHA 9170	00890	2024/4/30	2025/4/29
HF-AMP + AC source	EMCI	EMC051845SE	980633	2025/1/15	2026/1/14
HF-AMP + AC source	EMCI	EMC184045SE	980656	2025/1/15	2026/1/14
Test Software	Audix E3	15914a_20191106 tuv	PK-001087	N/A	N/A
30 MHz – 1 GHz					
Receiver	R&S	ESR7	102108	2024/7/4	2025/7/3
Bilog Antenna	SCHWARZBECK	VULB-9168	00951	2025/4/8	2026/4/7
LF-AMP	Agilent	8447D	2727A05146	2025/1/15	2026/1/14
Test Software	Audix E3	15914a_20191106 tuv	PK-001087	N/A	N/A
Below 30 MHz					
Receiver	R&S	ESR7	102108	2024/7/4	2025/7/3
Loop Antenna	SCHWARZBECK	FMZB 1519B	00215	2024/12/11	2025/12/10
Test Software	Audix E3	15914a_20191106 tuv	PK-001087	N/A	N/A

Test Procedures

For Radiated Emissions below 30 MHz

a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter chamber room. The table was rotated 360 degrees to determine the position of the highest radiation.
b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
c. Parallel (OPEN), perpendicular (CLOSE), and ground-parallel (GROUND) orientations of the antenna are set to make the measurement.
d. For each suspected emission, the EUT was arranged to its worst case and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
e. The test-receiver system was set to Quasi-Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.

Note:

1. The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 9 kHz at frequency below 30 MHz.
2. All modes of operation were investigated and the worst-case emissions are reported.

For Radiated Emissions above 30 MHz

a. The EUT was placed on the top of a rotating table 0.8 meters (for 30 MHz ~ 1 GHz) / 1.5 meters (for above 1 GHz) above the ground at 3 meter chamber room for test. The table was rotated 360 degrees to determine the position of the highest radiation.
b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
c. The height of antenna is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
e. The test-receiver system was set to quasi-peak detect function and specified bandwidth with maximum hold mode when the test frequency is below 1 GHz.
f. The test-receiver system was set to peak and average detected function and specified bandwidth with maximum hold mode when the test frequency is above 1 GHz. If the peak reading value also meets average limit, measurement with the average detector is unnecessary.

Note:

1. The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 120 kHz for Quasi-peak detection (QP) or Peak detection (PK) at frequency below 1 GHz.
2. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz and the video bandwidth is 3 MHz for Peak detection (PK) at frequency above 1 GHz.
3. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz and the video bandwidth is ≥ 1/T (Duty cycle < 98 %) or 10 Hz (Duty cycle ≥ 98 %) for Average detection (AV) at frequency above 1 GHz.
4. All modes of operation were investigated and the worst-case emissions are reported.
5. The Radiated Emissions testing was performed in the X(E1), Y(H) and Z(E2) axis orientation. The worst-case Axis orientation is recorded in this test report.
6. The emission levels of other frequencies (including the 10th harmonic of the highest fundamental frequency) are very lower than the limit and are not shown in the test report.

Test Results

Factor (dB/m) = Antenna Factor (dB/m) + Cable Loss (dB) – Amplifier (dB)
Level (dBuV/m) = Reading (dBuV) + Factor (dB/m)

Please refer to Appendix B.

5.2 Mains Emission

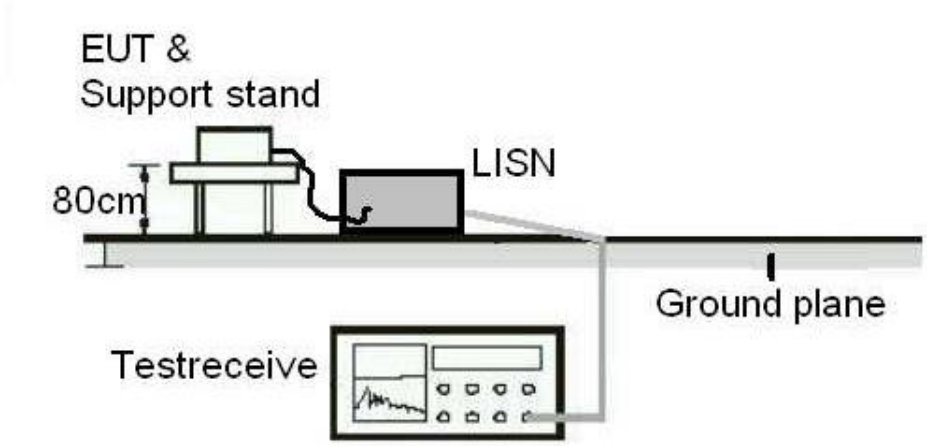
5.2.1 Mains Conducted Emission

Limit

Mains Conducted Emission as defined in §15.207 must comply with the mains conducted emission limits.

Kind of Test Site Shielded room

Test Setup



Test Instruments

Test Date: 2025/4/23-2025/4/24

Kind of Equipment	Manufacturer	Type	S/N	Calibration Date	Calibration Due Date
Two-Line V-Network	Rohde & Schwarz	ENV216	101938	2024/10/22	2025/10/21
EMI Test Receiver	R&S	ESCI	101094	2024/11/25	2025/11/24

Test Procedures

a. The EUT was placed 0.4 meters from the conducting wall of the shielded room with EUT being connected to the power mains through a line impedance stabilization network (LISN). Other support units were connected to the power mains through another LISN. The two LISNs provide 50 ohm/50 uH of coupling impedance for the measuring instrument.
b. Both lines of the power mains connected to the EUT were checked for maximum conducted interference.
c. The frequency range from 150 kHz to 30 MHz was searched. Emission levels under (Limit – 20 dB) was not recorded.

Note: The resolution bandwidth and video bandwidth of test receiver is 9 kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15 MHz – 30 MHz.

Test Results

Please refer to Appendix B.